

Notic of R ferences Cit d	Application/Control No. 09/936,040	Applicant(s)/Patent Under Reexamination YUDASAKA ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,034,408 /	03-2000	Ghoshal	257/467
	D	US-6,064,091 /	05-2000	Deane et al	257/347
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	K	US-			
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	M	US-			

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	N	JP 10-79513 /	03-1998	Japan	Suzuki et al.	
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NON-PATENT DOCUMENTS

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